


<b>Search Notes</b>  	<b>Application/Control No.</b>  10681523	<b>Applicant(s)/Patent Under Reexamination</b>  LI ET AL.
	<b>Examiner</b>  Liu, Lin	<b>Art Unit</b>  2145

SEARCHED			
Class	Subclass	Date	Examiner
709	236	07/19/2007	L.L
370	395.52	07/19/2007	L.L

SEARCH NOTES		
Search Notes	Date	Examiner
Text search of USPAT, USPGPUB, EPO, JPO, DERWENT, IBM_TDB, see search history printout.	07/19/2007	L.L
L1: 709/236.ccls. and (@ad<20031008) reviewed consicely	07/19/2007	L.L
709/236.ccls. not L1, reviewed cursory.	07/19/2007	L.L
Diaglog search attached	07/23/2007	L.L
Consulted with Primary examiner Patrice Winder for the double patent rejection	07/19/2007	L.L
Consulted with examiner Jeffrey Swearingen for the search.	07/20/2007	L.L

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner